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Contents

VERIFICATION AND ALIGNMENT

11488 04	An approach to upgrading the beam transport system at the Navy Precision Optical Interferometer [11488-2]
11488 05	Verification of the optical system of the 9.7-m prototype Schwarzschild-Couder Telescope [11488-3]
11488 06	Linearization of defocus for projector optical alignment in structured light illumination systems [11488-4]
11488 07	Practical measurement of cell-phone camera lens focal length [11488-5]
	TOLERANCING AND ALIGNMENT
11488 08	Study of tolerancing optimization approaches in Zemax for as-built performance [11488-6]

- 11488 09Sensitivity analysis of the CTE and thermo-optical coefficients of a passively athermalized lens
[11488-7]
- 11488 0A Tolerance eigenmodes of optical systems (Invited Paper) [11488-8]
- 11488 OBRecent developments in tolerancing methods for imaging spectrometers [11488-9]
- 11488 0C Exact wavefront refracted through cemented doublet lenses [11488-10]

ALIGNMENT AND METHODS I

- 11488 OF Adapting a prototype zoom lens to work outside its zoom range [11488-13]
- 11488 0G Using spherical aberration as a tool in aligning off-axis aspheric mirrors, as described in "Introduction to Optical Alignment Techniques", a short course long offered through SPIE [11488-14]

	ALIGNMENT AND METHODS II
11488 01	Alignment and verification testing of the GPS LRA test bed [11488-16]
11488 OJ	Aligning reflecting optics with Bessel beams [11488-17]
11488 OK	Hartmann testing and vibration for RST (WFIRST) [11488-18]
11488 OL	Data analysis algorithm for double-pass testing of the Roman Space Telescope [11488-19]
	POSTER SESSION
11488 00	Development of a vacuum-compatible manipulator to calibrate wide field UV imagers for CubeSats [11488-22]
11488 OP	Optical characterization of electro-optics lenses for researching in optics [11488-23]

11488 0Q Wavelength detection method using vortices [11488-24]